

Preliminary

SIDC46D170H

Fast switching diode chip in EMCON 3-Technology

FEATURES:

- 1700V EMCON 3 technology 200 µm chip
- soft, fast switching
- low reverse recovery charge
- small temperature coefficient
- This chip is used for:
- EUPEC power modules



Applications:resonant applications, drives

Chip Type	V _R	I _F	Die Size	Package	Ordering Code
SIDC46D170H	1700V	75A	6.8 x 6.8 mm ²	sawn on foil	Q67050-A4175- A001

MECHANICAL PARAMETER:

		1			
Raster size	6.8 x 6.8				
Area total / active	46.24 / 34.04	mm ²			
Anode pad size	4.78 x 4.78				
Thickness	200	μm			
Wafer size	150	mm			
Flat position	180	deg			
Max. possible chips per wafer	304 pcs				
Passivation frontside	Photoimide				
Anode metallization	3200 nm Al Si Cu				
Cathode metallization	Ni Ag –system suitable for epoxy and soft solder die bor				
Die bond	electrically conductive glue or solder				
Wire bond	AI, ≤500µm				
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm				
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C				



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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V _{RRM}		1700	V
Continuous forward current limited by	1		75	
T _{jmax}	/ _F		75	
Single pulse forward current	I _{FSM}	$t_P = 10 ms sinusoidal$	tbd	A
(depending on wire bond configuration)	1-21			
Maximum repetitive forward current	1		150	
limited by T _{jmax}	I _{FRM}		150	
Operating junction and storage temperature	T_{j} , T_{stg}		-55+150	°C

Static Electrical Characteristics (tested on chip), T_j =25 °C, unless otherwise specified

Parameter	Symbol	Cond	Value			Unit	
Falameter	Symbol	Conditions -		min.	Тур.	max.	Onit
Reverse leakage current	I _R	V _R =1700V	<i>T_j</i> =25 ° <i>C</i>			250	μA
Cathode-Anode breakdown Voltage	V _{Br}	I _R =0.25mA	<i>T_j</i> =25°C	1700			V
Forward voltage drop	V _F	I _F =75A	<i>T_j</i> =25°C		1.8		V

Dynamic Electrical Characteristics, at T_j = 25 °C, unless otherwise specified, tested at component

Parameter	Symbol	Conditions			Value	Value	
Falallelel	Symbol			min.	Тур.	max.	– Unit
Reverse recovery time	t _{rr1}	I _F =75A	$T_j = 25 \ ^\circ C$		tbd		
	t _{rr2}	<i>di/dt=A/m</i> s <i>V_R=V</i>	$T_j = 125 \ ^\circ C$				ns
Peak recovery current	I _{RRM1}	$I_F=75A$	$T_j = 25 \ ^{\circ}C$		tbd		Δ
	I _{RRM2}	di/dt=A/ms V _R =V	$T_j = 125 \ ^{\circ}C$		tbd		A
Reverse recovery charge	Q _{rr1}	$I_F=75A$	<i>T_j</i> =25°C		tbd		
	Q _{rr2}	<i>di/dt=A/ms</i> <i>V_R=V</i>	<i>T_j</i> =125°C		tbd		μC
Peak rate of fall of reverse	di _{rr1} /dt	I _F =75A	$T_{\rm j}=25^{\circ}C$		tbd		A /
recovery current	di _{rr2} /dt	<i>di/dt</i> =A/ m s V _R =V	<i>T_j</i> =125°C				A/μs
Softness	S1	$I_{\rm F}=75A$	<i>T_j</i> =25°C		tbd		1
	S2	$di/dt = \cdots A/ms$ $V_R = \cdots V$	<i>T_j</i> =125°C				

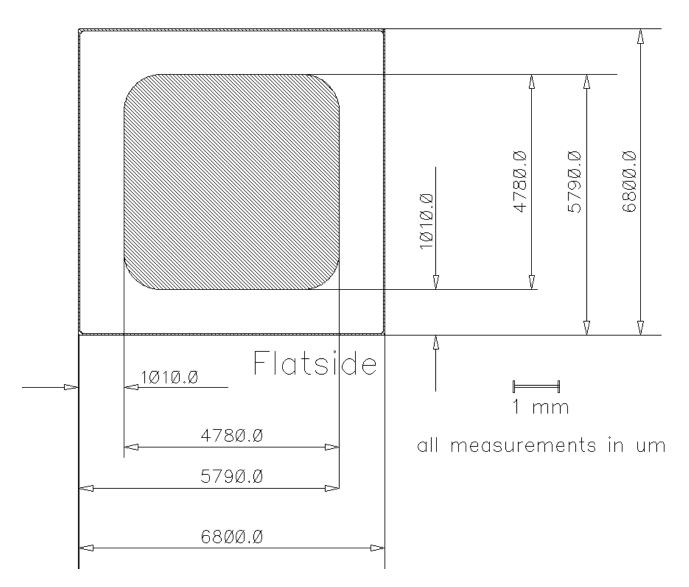


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CHIP DRAWING:

L447A1





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	INFINEON TECHNOLOGIES /	tbd
device data sheet	EUPEC	lbu

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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